

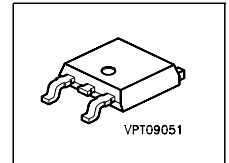
## Cool MOS™ Power Transistor

### Feature

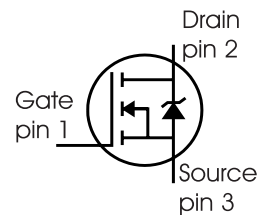
- New revolutionary high voltage technology
- Worldwide best  $R_{DS(on)}$  in TO-252
- Ultra low gate charge
- Periodic avalanche rated
- Extreme  $dv/dt$  rated
- Ultra low effective capacitances
- Improved transconductance

|                     |     |          |
|---------------------|-----|----------|
| $V_{DS} @ T_{jmax}$ | 560 | V        |
| $R_{DS(on)}$        | 0.6 | $\Omega$ |
| $I_D$               | 7.6 | A        |

P-TO252-3-1



| Type       | Package     | Ordering Code | Marking |
|------------|-------------|---------------|---------|
| SPD08N50C3 | P-TO252-3-1 | Q67040-S4569  | 08N50C3 |



### Maximum Ratings, at $T_C = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                                                                 | Symbol              | Value       | Unit             |
|---------------------------------------------------------------------------|---------------------|-------------|------------------|
| Continuous drain current                                                  | $I_D$               | 7.6         | A                |
| $T_C = 25^\circ\text{C}$                                                  |                     | 7.6         |                  |
| $T_C = 100^\circ\text{C}$                                                 |                     | 4.6         |                  |
| Pulsed drain current, $t_p$ limited by $T_{jmax}$                         | $I_{D\text{ puls}}$ | 22.8        |                  |
| Avalanche energy, single pulse                                            | $E_{AS}$            | 230         | mJ               |
| $I_D=5.5\text{A}$ , $V_{DD}=50\text{V}$                                   |                     |             |                  |
| Avalanche energy, repetitive $t_{AR}$ limited by $T_{jmax}$ <sup>1)</sup> | $E_{AR}$            | 0.5         |                  |
| $I_D=7.6\text{A}$ , $V_{DD}=50\text{V}$                                   |                     |             |                  |
| Avalanche current, repetitive $t_{AR}$ limited by $T_{jmax}$              | $I_{AR}$            | 7.6         | A                |
| Gate source voltage                                                       | $V_{GS}$            | $\pm 20$    | V                |
| Gate source voltage AC ( $f > 1\text{Hz}$ )                               | $V_{GS}$            | $\pm 30$    |                  |
| Power dissipation, $T_C = 25^\circ\text{C}$                               | $P_{tot}$           | 83          | W                |
| Operating and storage temperature                                         | $T_j, T_{stg}$      | -55... +150 | $^\circ\text{C}$ |

## Maximum Ratings

| Parameter                                                                                                           | Symbol  | Value | Unit |
|---------------------------------------------------------------------------------------------------------------------|---------|-------|------|
| Drain Source voltage slope<br>$V_{DS} = 400 \text{ V}$ , $I_D = 7.6 \text{ A}$ , $T_j = 125 \text{ }^\circ\text{C}$ | $dv/dt$ | 50    | V/ns |

## Thermal Characteristics

| Parameter                                                                    | Symbol     | Values |      |      | Unit             |
|------------------------------------------------------------------------------|------------|--------|------|------|------------------|
|                                                                              |            | min.   | typ. | max. |                  |
| Thermal resistance, junction - case                                          | $R_{thJC}$ | -      | -    | 1.5  | K/W              |
| Thermal resistance, junction - ambient, leaded                               | $R_{thJA}$ | -      | -    | 75   |                  |
| SMD version, device on PCB:<br>@ min. footprint                              | $R_{thJA}$ | -      | -    | 75   |                  |
| @ 6 cm <sup>2</sup> cooling area <sup>2)</sup>                               |            | -      | -    | 50   |                  |
| Soldering temperature,<br>1.6 mm (0.063 in.) from case for 10s <sup>3)</sup> | $T_{sold}$ | -      | -    | 260  | $^\circ\text{C}$ |

## Electrical Characteristics

| Parameter                                   | Symbol        | Conditions                                                                                         | Values |            |          | Unit          |
|---------------------------------------------|---------------|----------------------------------------------------------------------------------------------------|--------|------------|----------|---------------|
|                                             |               |                                                                                                    | min.   | typ.       | max.     |               |
| Drain-source breakdown voltage              | $V_{(BR)DSS}$ | $V_{GS}=0\text{V}$ , $I_D=0.25\text{mA}$                                                           | 500    | -          | -        | V             |
| Drain-Source avalanche<br>breakdown voltage | $V_{(BR)DS}$  | $V_{GS}=0\text{V}$ , $I_D=7.6\text{A}$                                                             | -      | 600        | -        |               |
| Gate threshold voltage                      | $V_{GS(th)}$  | $I_D=350\mu\text{A}$ , $V_{GS}=V_{DS}$                                                             | 2.1    | 3          | 3.9      |               |
| Zero gate voltage drain current             | $I_{DSS}$     | $V_{DS}=500\text{V}$ , $V_{GS}=0\text{V}$ ,<br>$T_j=25^\circ\text{C}$ ,<br>$T_j=150^\circ\text{C}$ | -<br>- | 0.5<br>-   | 1<br>100 | $\mu\text{A}$ |
| Gate-source leakage current                 | $I_{GSS}$     | $V_{GS}=20\text{V}$ , $V_{DS}=0\text{V}$                                                           | -      | -          | 100      |               |
| Drain-source on-state resistance            | $R_{DS(on)}$  | $V_{GS}=10\text{V}$ , $I_D=4.6\text{A}$ ,<br>$T_j=25^\circ\text{C}$ ,<br>$T_j=150^\circ\text{C}$   | -<br>- | 0.5<br>1.5 | 0.6<br>- | $\Omega$      |
| Gate input resistance                       | $R_G$         | $f=1\text{MHz}$ , open Drain                                                                       | -      | 1.2        | -        |               |

**Electrical Characteristics** , at  $T_j = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified

| Parameter                                                     | Symbol       | Conditions                                                                                   | Values |      |      | Unit |
|---------------------------------------------------------------|--------------|----------------------------------------------------------------------------------------------|--------|------|------|------|
|                                                               |              |                                                                                              | min.   | typ. | max. |      |
| Transconductance                                              | $g_{fs}$     | $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ ,<br>$I_D = 4.6\text{A}$                       | -      | 6    | -    | S    |
| Input capacitance                                             | $C_{iss}$    | $V_{GS} = 0\text{V}$ , $V_{DS} = 25\text{V}$ ,<br>$f = 1\text{MHz}$                          | -      | 750  | -    | pF   |
| Output capacitance                                            | $C_{oss}$    |                                                                                              | -      | 350  | -    |      |
| Reverse transfer capacitance                                  | $C_{rss}$    |                                                                                              | -      | 12   | -    |      |
| Effective output capacitance, <sup>4)</sup><br>energy related | $C_{o(er)}$  | $V_{GS} = 0\text{V}$ ,<br>$V_{DS} = 0\text{V to } 400\text{V}$                               | -      | 56   | -    | pF   |
| Effective output capacitance, <sup>5)</sup><br>time related   | $C_{o(tr)}$  |                                                                                              | -      | 30   | -    |      |
| Turn-on delay time                                            | $t_{d(on)}$  | $V_{DD} = 400\text{V}$ , $V_{GS} = 0/10\text{V}$ ,<br>$I_D = 7.6\text{A}$ , $R_G = 12\Omega$ | -      | 6    | -    | ns   |
| Rise time                                                     | $t_r$        |                                                                                              | -      | 5    | -    |      |
| Turn-off delay time                                           | $t_{d(off)}$ |                                                                                              | -      | 60   | -    |      |
| Fall time                                                     | $t_f$        |                                                                                              | -      | 7    | -    |      |

**Gate Charge Characteristics**

|                       |                 |                                                                                      |   |    |   |    |
|-----------------------|-----------------|--------------------------------------------------------------------------------------|---|----|---|----|
| Gate to source charge | $Q_{gs}$        | $V_{DD} = 400\text{V}$ , $I_D = 7.6\text{A}$                                         | - | 3  | - | nC |
| Gate to drain charge  | $Q_{gd}$        |                                                                                      | - | 17 | - |    |
| Gate charge total     | $Q_g$           | $V_{DD} = 400\text{V}$ , $I_D = 7.6\text{A}$ ,<br>$V_{GS} = 0\text{ to } 10\text{V}$ | - | 32 | - |    |
| Gate plateau voltage  | $V_{(plateau)}$ | $V_{DD} = 400\text{V}$ , $I_D = 7.6\text{A}$                                         | - | 5  | - | V  |

<sup>1</sup> Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV} = E_{AR} \cdot f$ .

<sup>2</sup> Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

<sup>3</sup> Soldering temperature for TO-263: 220°C, reflow

<sup>4</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

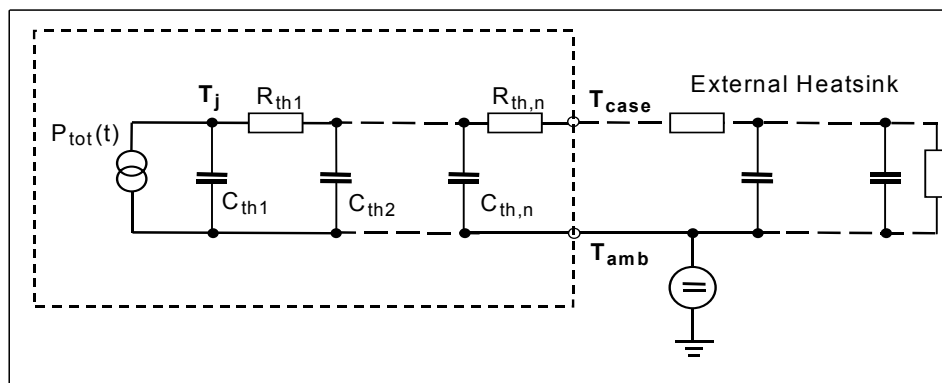
<sup>5</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                                     | Symbol       | Conditions                                                           | Values |      |      | Unit                   |
|-----------------------------------------------|--------------|----------------------------------------------------------------------|--------|------|------|------------------------|
|                                               |              |                                                                      | min.   | typ. | max. |                        |
| Inverse diode continuous forward current      | $I_S$        | $T_C=25^\circ\text{C}$                                               | -      | -    | 7.6  | A                      |
| Inverse diode direct current, pulsed          | $I_{SM}$     |                                                                      | -      | -    | 22.8 |                        |
| Inverse diode forward voltage                 | $V_{SD}$     | $V_{GS}=0\text{V}$ , $I_F=I_S$                                       | -      | 1    | 1.2  | V                      |
| Reverse recovery time                         | $t_{rr}$     | $V_R=400\text{V}$ , $I_F=I_S$ ,<br>$di_F/dt=100\text{A}/\mu\text{s}$ | -      | 370  | -    | ns                     |
| Reverse recovery charge                       | $Q_{rr}$     |                                                                      | -      | 3.6  | -    | $\mu\text{C}$          |
| Peak reverse recovery current                 | $I_{rrm}$    |                                                                      | -      | 25   | -    | A                      |
| Peak rate of fall of reverse recovery current | $di_{rr}/dt$ |                                                                      | -      | 700  | -    | $\text{A}/\mu\text{s}$ |

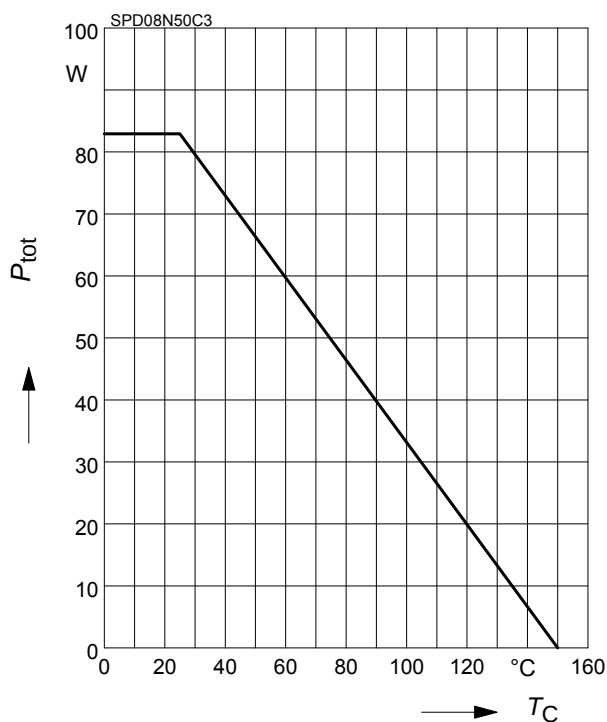
**Typical Transient Thermal Characteristics**

| Symbol             | Value | Unit | Symbol              | Value     | Unit |
|--------------------|-------|------|---------------------|-----------|------|
|                    | typ.  |      |                     | typ.      |      |
| Thermal resistance |       |      | Thermal capacitance |           |      |
| $R_{th1}$          | 0.024 | K/W  | $C_{th1}$           | 0.00012   | Ws/K |
| $R_{th2}$          | 0.046 |      | $C_{th2}$           | 0.0004578 |      |
| $R_{th3}$          | 0.085 |      | $C_{th3}$           | 0.000645  |      |
| $R_{th4}$          | 0.308 |      | $C_{th4}$           | 0.001867  |      |
| $R_{th5}$          | 0.317 |      | $C_{th5}$           | 0.004795  |      |
| $R_{th6}$          | 0.112 |      | $C_{th6}$           | 0.045     |      |



### 1 Power dissipation

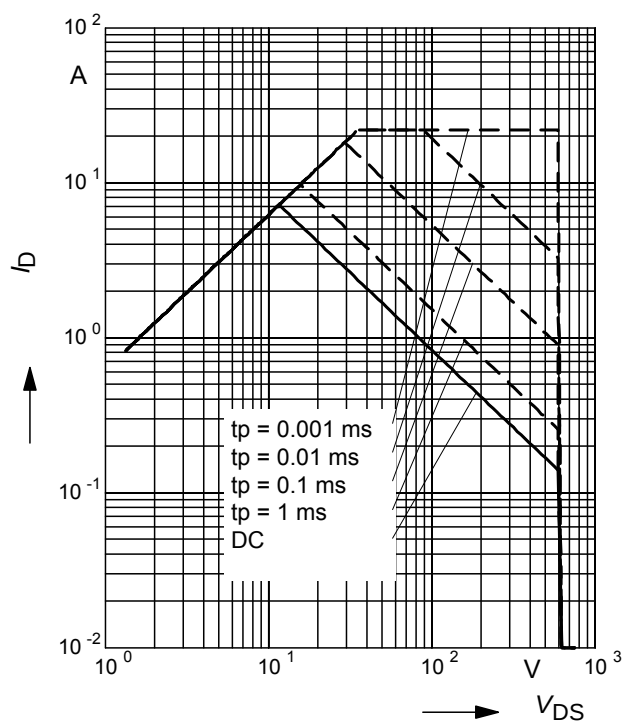
$$P_{\text{tot}} = f(T_C)$$



### 2 Safe operating area

$$I_D = f(V_{DS})$$

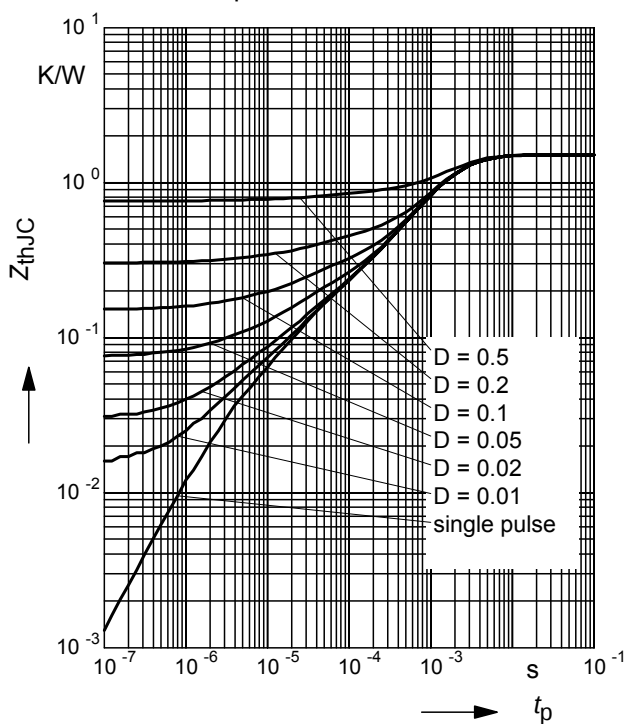
parameter :  $D = 0$  ,  $T_C = 25^\circ\text{C}$



### 3 Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

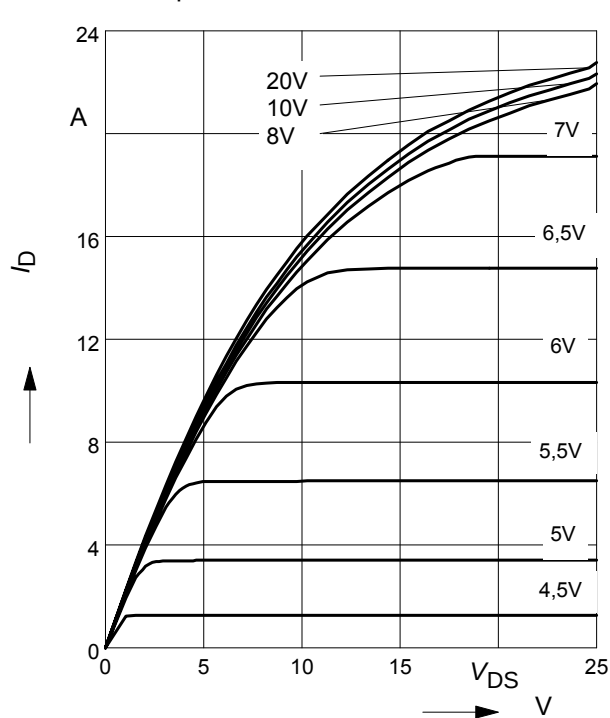
parameter:  $D = t_p/T$



### 4 Typ. output characteristic

$$I_D = f(V_{DS}); T_J = 25^\circ\text{C}$$

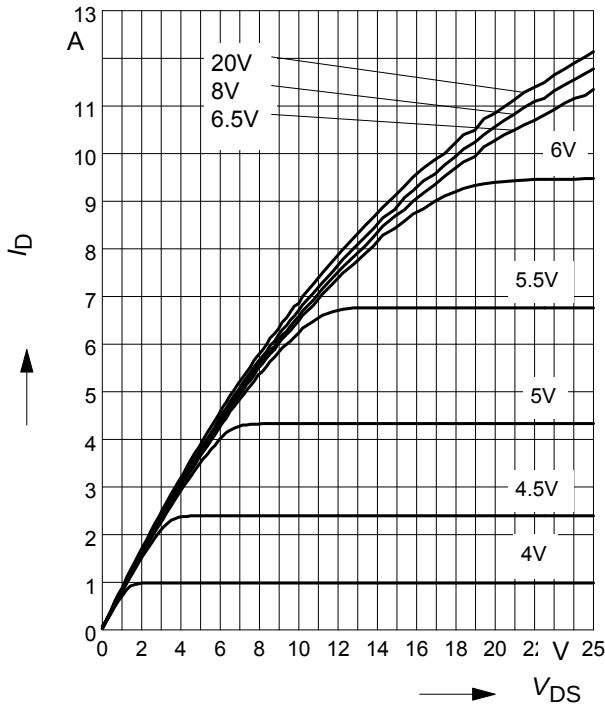
parameter:  $t_p = 10 \mu\text{s}$ ,  $V_{GS}$



### 5 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 150^\circ\text{C}$$

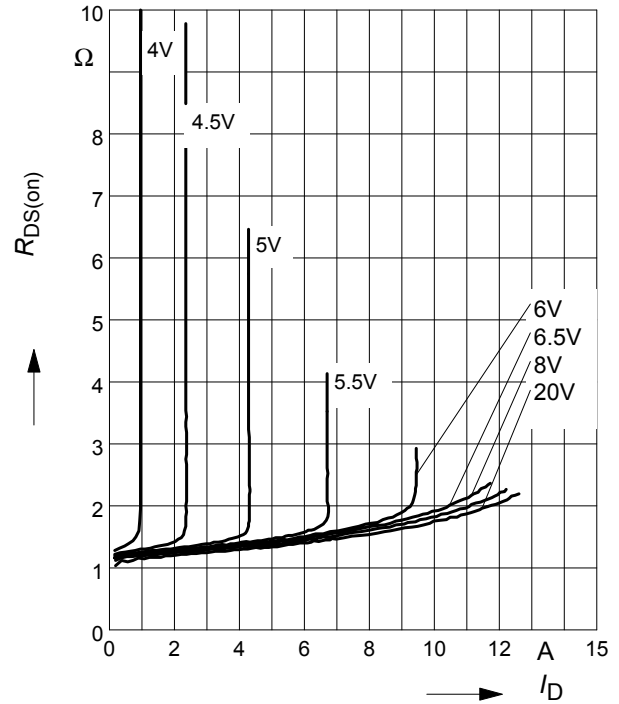
parameter:  $t_p = 10 \mu\text{s}$ ,  $V_{GS}$



### 6 Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$

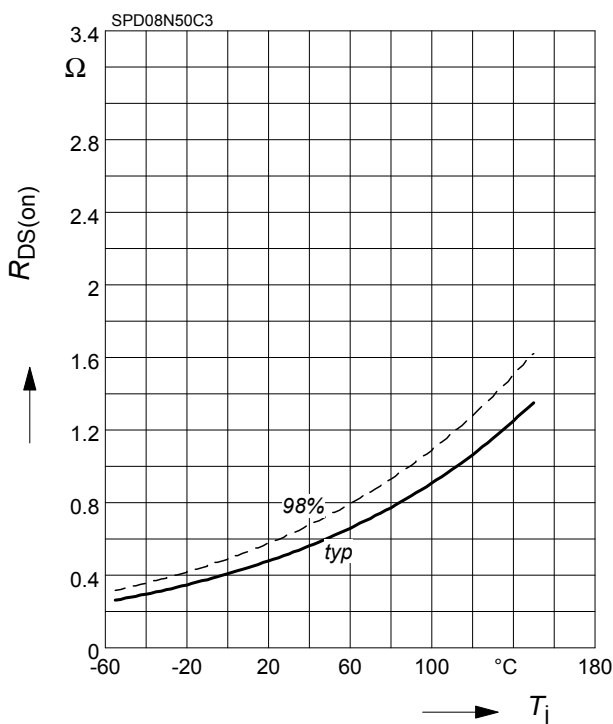
parameter:  $T_j = 150^\circ\text{C}$ ,  $V_{GS}$



### 7 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

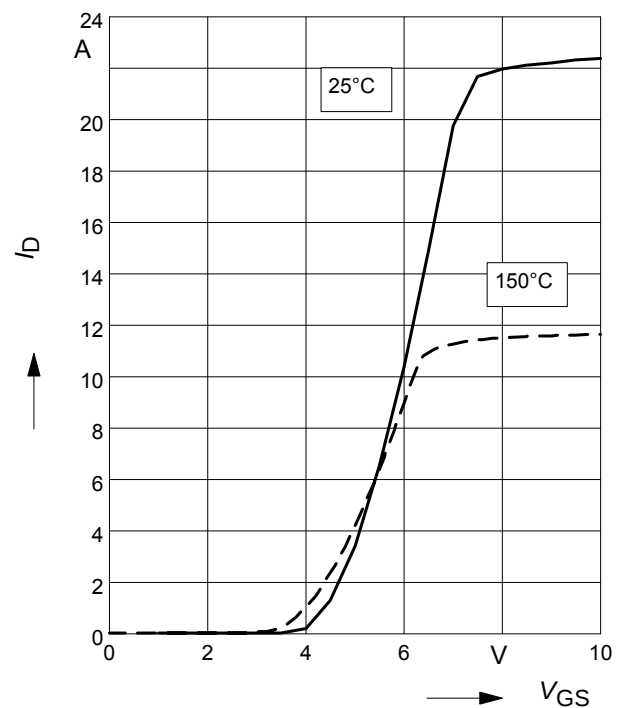
parameter:  $I_D = 4.6 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



### 8 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)\text{max}}$$

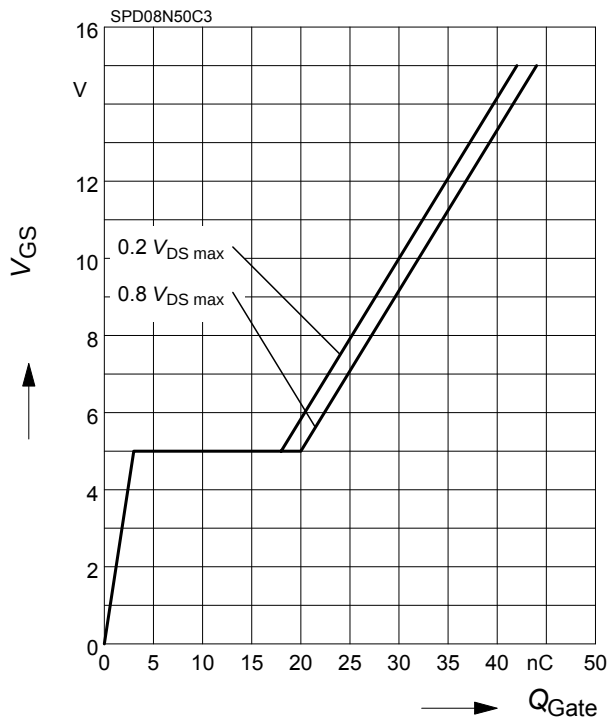
parameter:  $t_p = 10 \mu\text{s}$



## 9 Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

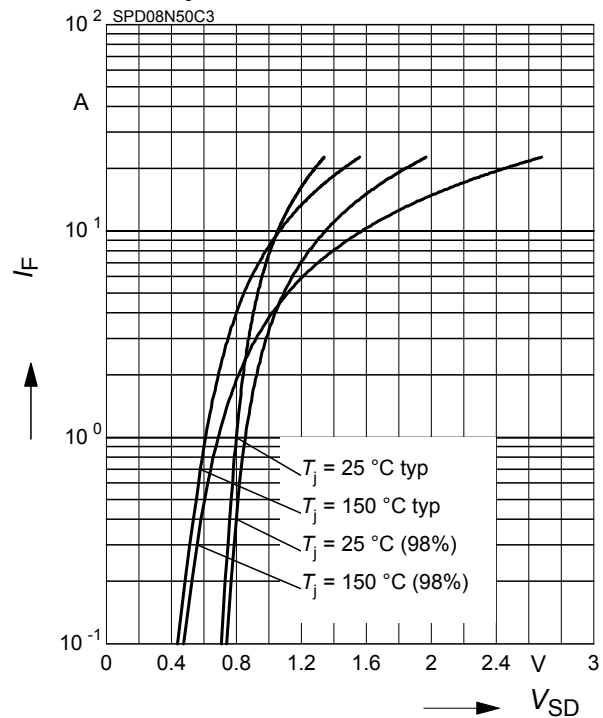
parameter:  $I_D = 7.6$  A pulsed



## 10 Forward characteristics of body diode

$$I_F = f(V_{SD})$$

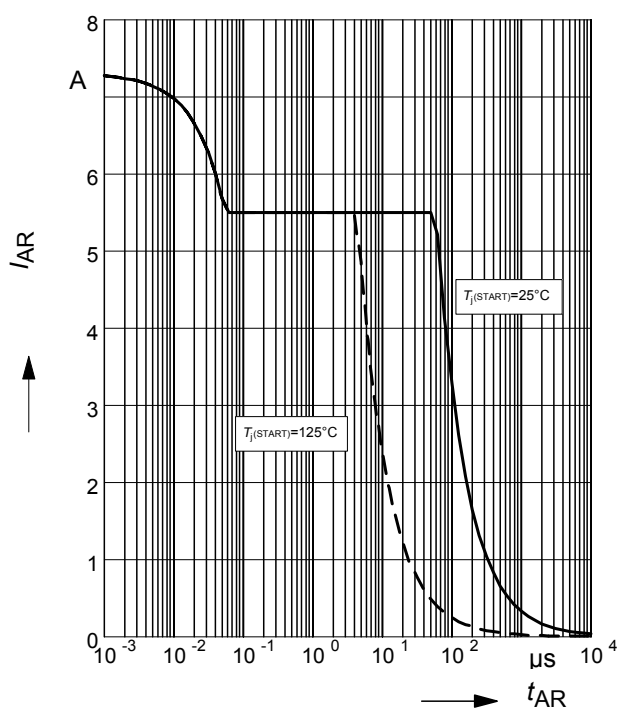
parameter:  $T_j$ ,  $t_p = 10$   $\mu$ s



## 11 Avalanche SOA

$$I_{AR} = f(t_{AR})$$

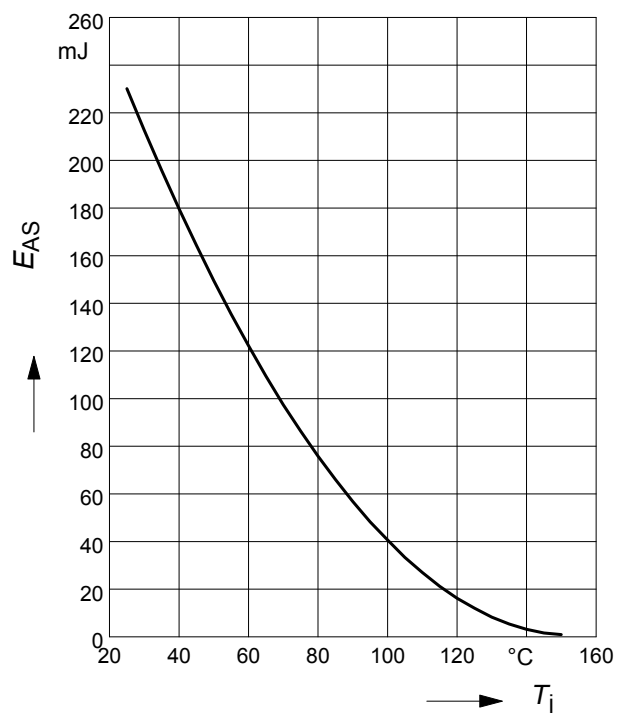
par.:  $T_j \leq 150$  °C



## 12 Avalanche energy

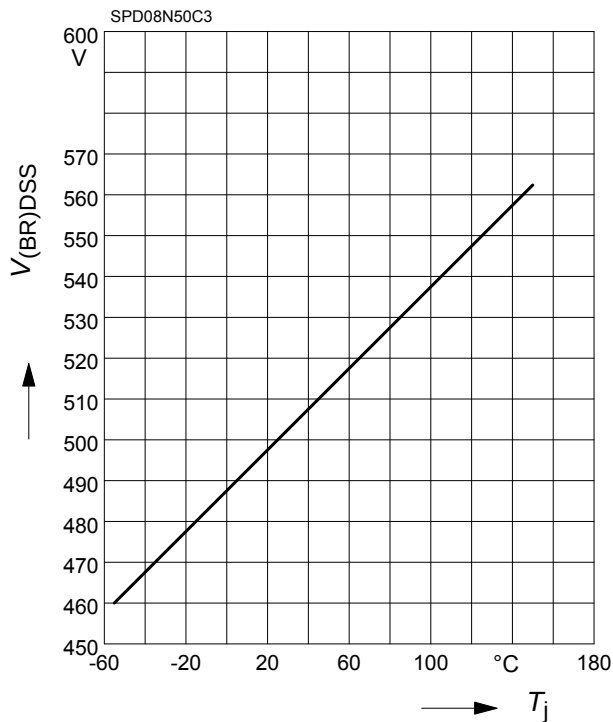
$$E_{AS} = f(T_j)$$

par.:  $I_D = 5.5$  A,  $V_{DD} = 50$  V



### 13 Drain-source breakdown voltage

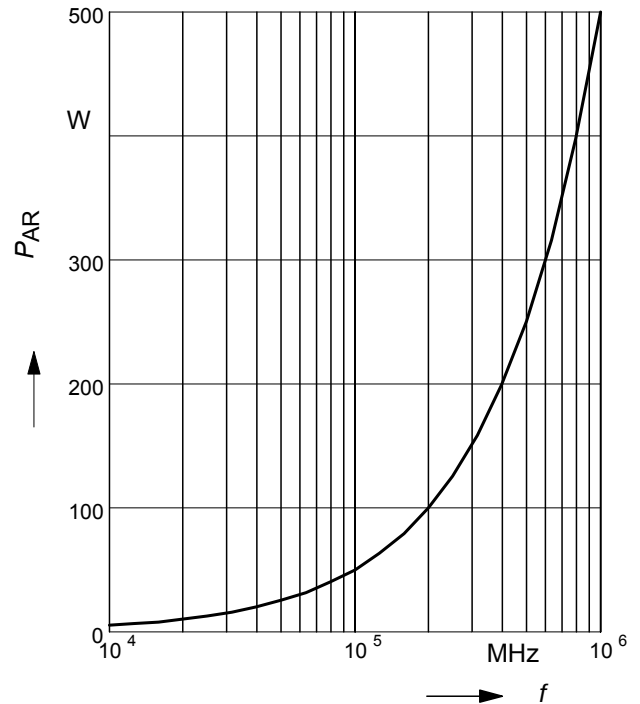
$$V_{(BR)DSS} = f(T_j)$$



### 14 Avalanche power losses

$$P_{AR} = f(f)$$

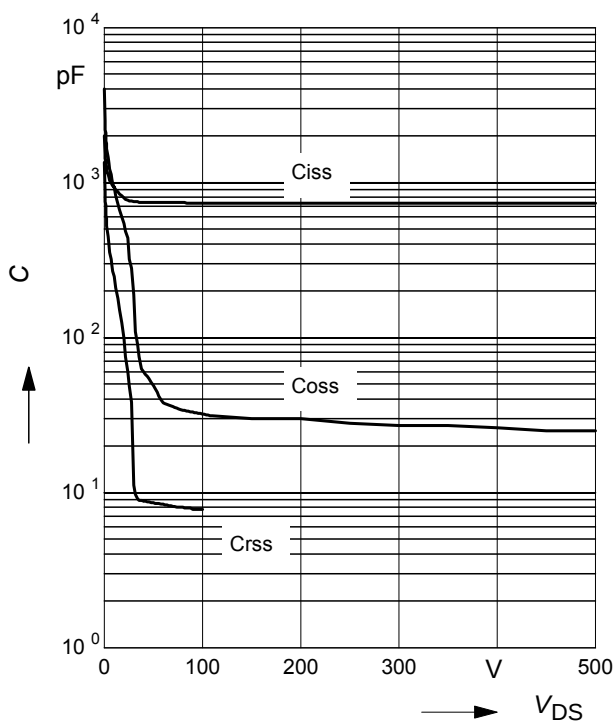
parameter:  $E_{AR}=0.5\text{mJ}$



### 15 Typ. capacitances

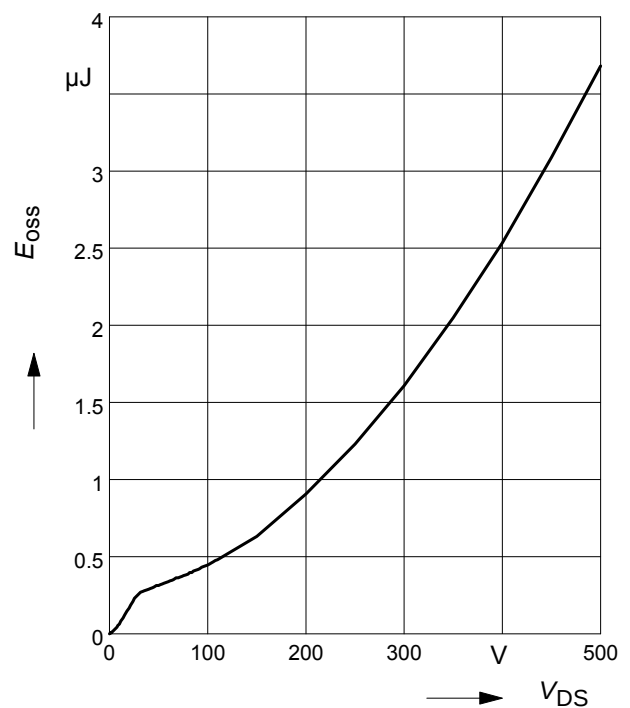
$$C = f(V_{DS})$$

parameter:  $V_{GS}=0\text{V}$ ,  $f=1\text{ MHz}$

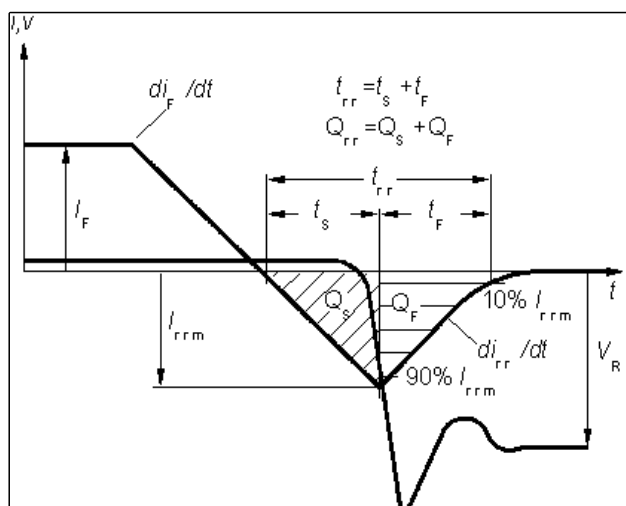


### 16 Typ. $C_{OSS}$ stored energy

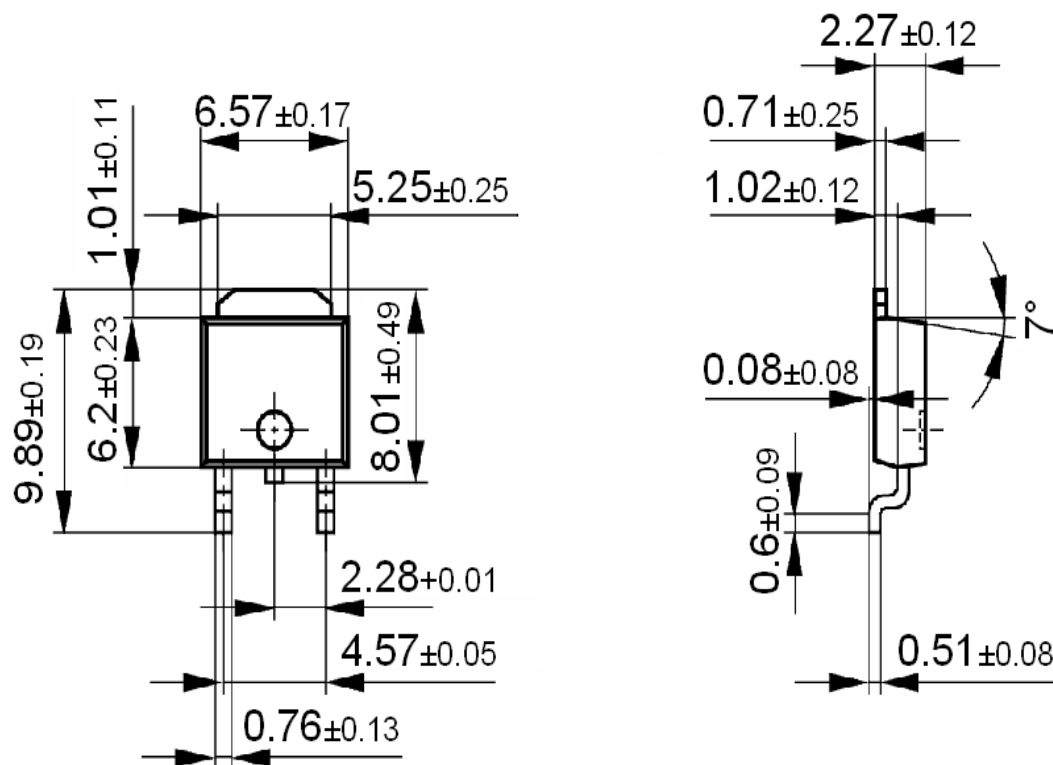
$$E_{OSS}=f(V_{DS})$$



# Definition of diodes switching characteristics



P-TO-252-3-1 (D-PAK)



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